# Feature model analysis and configuration: a 10 years journey with configuration stops

**David Benavides** 

<u>benavides@us.es</u>

Configuration workshop, Graz – Sept 2018



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# **Graz**miércoles, 22:00 Despejado

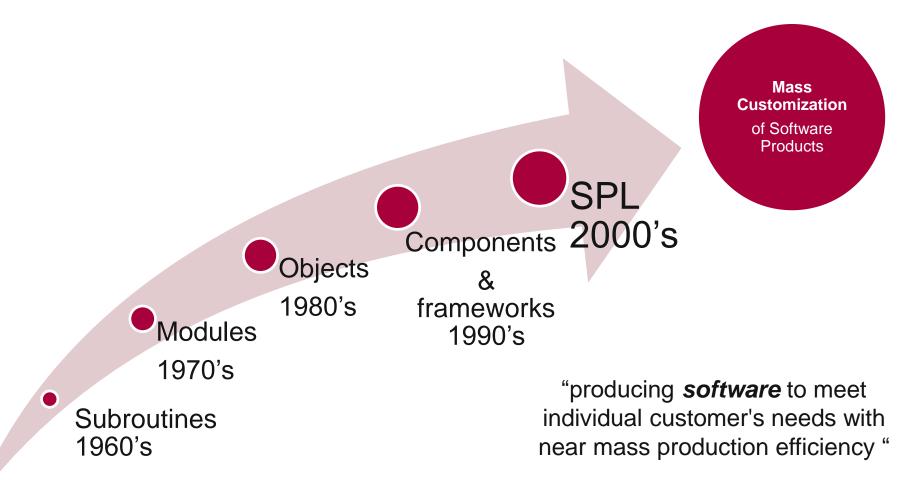
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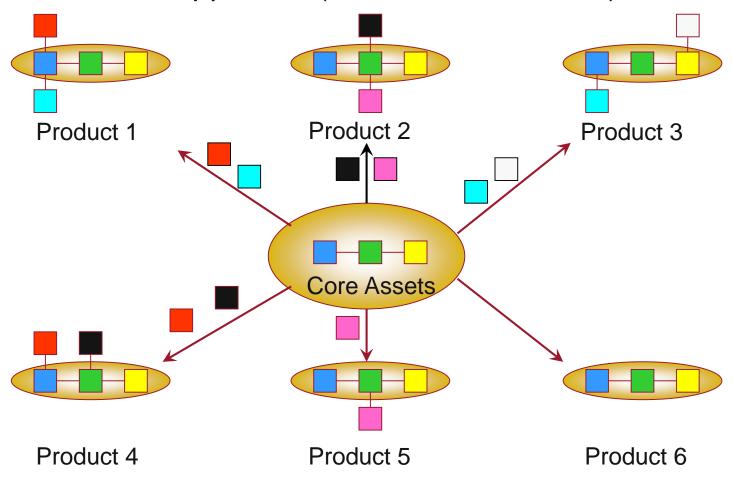


### Scope of the journey: software product lines



### **Software product lines**

#### Product Lines Approach (mass customization)



# A more practical view of the SPL framework

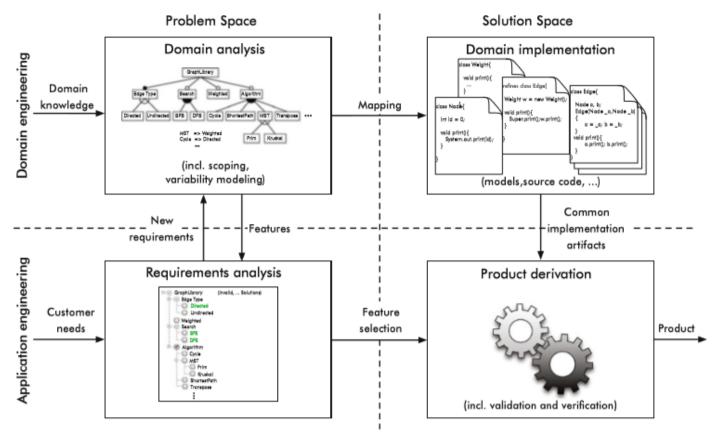


Fig. 1.1 An overview on software product-line engineering

# How to model variability?

# How to model variability

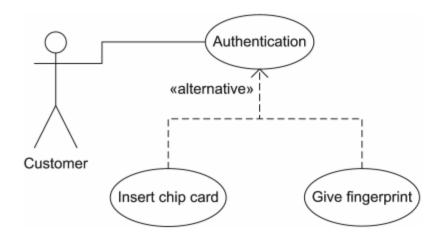
Expressing variability

Outside the model

Positive variability

Negative variability

# Inside the model



Get account information «option»

Customer

Print balance

Figure 5: Example of an alternative relationship

Figure 6: Example of an optional relationship

# How to model variability

Expressing variability

Outside the model

Positive variability

Negative variability

# Outside the model **Variability Model** Sua

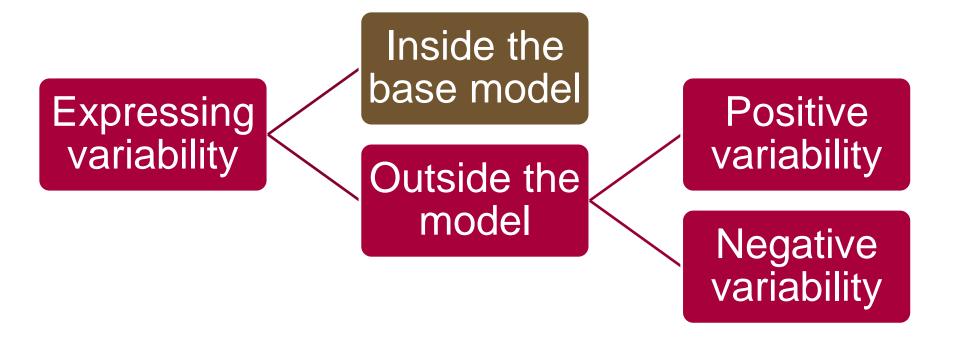
**Base models** 

Design

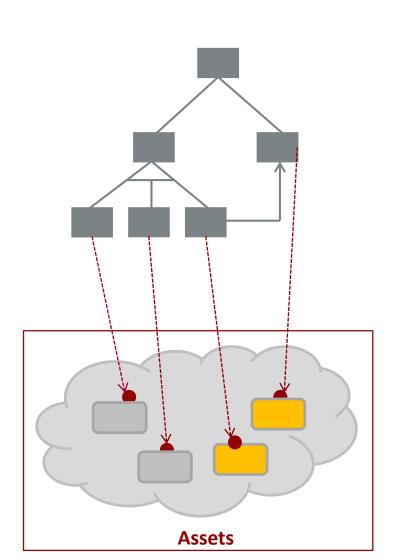
**Components** 

Requirements

# How to model variability



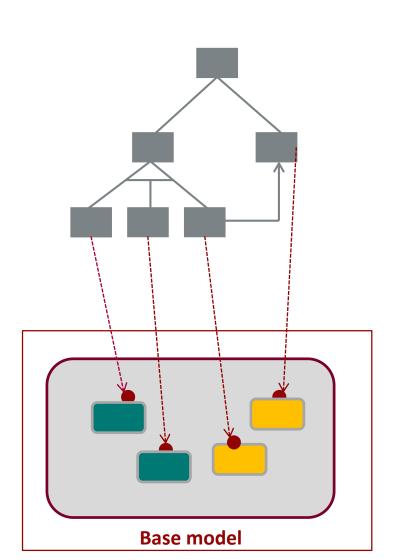
# Positive variability







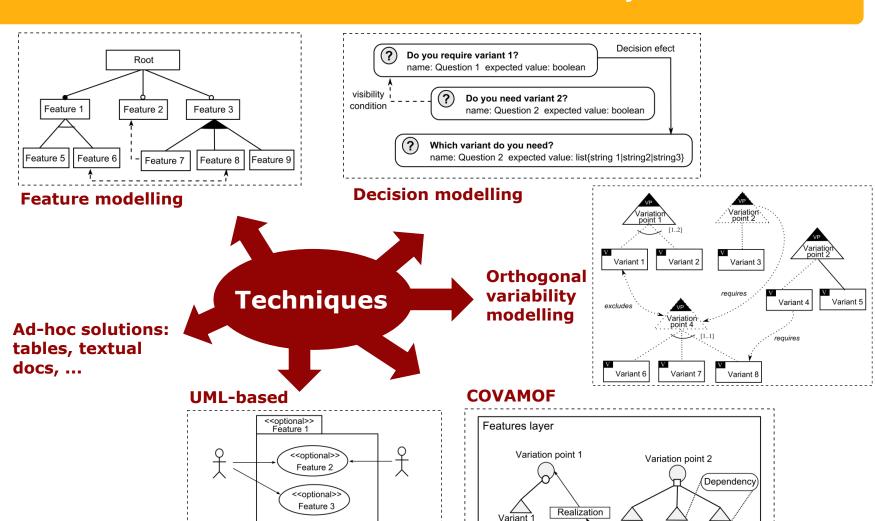
# Negative variability







# How to model variability



Architecture layer

<<at-least-one>>

Feature 4

<<optional>>

Feature 6

<<optional>>

Feature 7

<<default>>

Feature 5

Variant 2 Variant 3 Variant 4

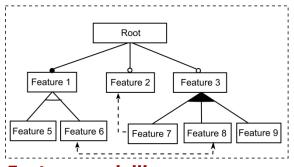
Variation point 3

Variant 5

Variation point 4

Variant 6 Variant 7

# How to model variability





Feature modelling Decision modelli





Ad-hoo tables,

# Feature models were first introduced by Kang et al. in 1990

<-optional>>
Feature 1

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Feature 2

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Feature 3

</optional>>
Feature 3

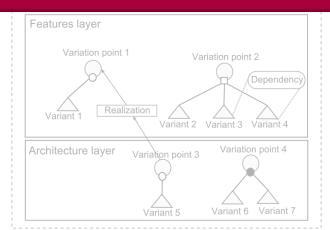
</optional>>
Feature 4

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Feature 4

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Feature 5

Feature 6

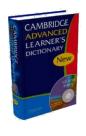
Feature 7



#### **Feature models**

# How to specify a particular product?

#### FEATURE



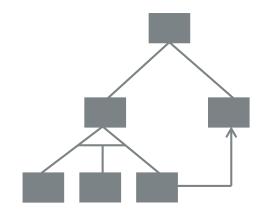
"An important part of something"



"A prominent or distinctive characteristic of a software system"

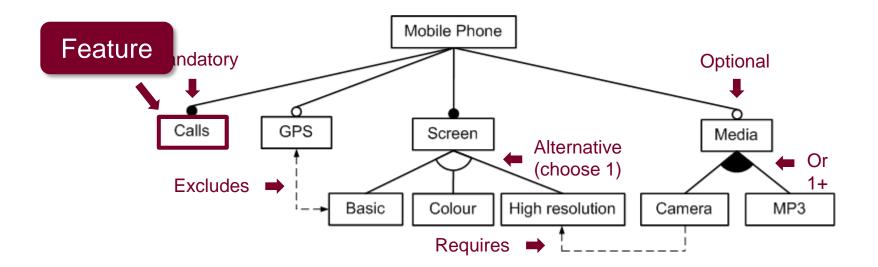
#### **Feature models**

# How to specify an SPL?



"Feature Model: A hierarchically arranged set of features to represent all possible products of an SPL"

### **Feature models**

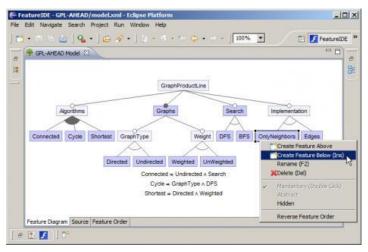




# pure-systems







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#### Formal methods

First stop: Automated Analysis of FM Second stop: Explanations on FM analysis Third stop: Testing on FM analysis tools

Forth stop:
Applications
of the
Automate
analysis of
feature
models

Tool support

#### Formal methods

First stop: Automated Analysis of FM Second stop: Explanations on FM analysis

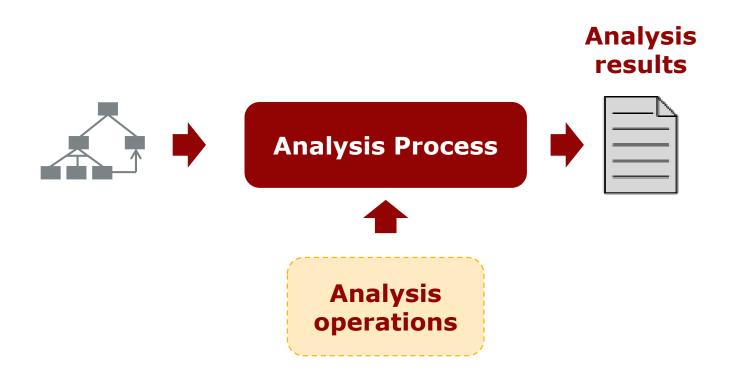
Third stop:
Testing on
FM analysis
tools

Forth stop:
Applications
of the
Automate
analysis of
feature
models

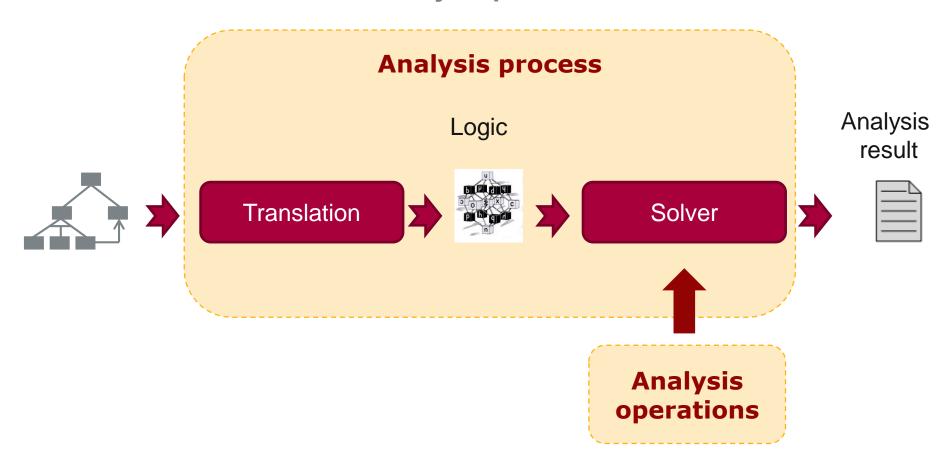
**Tool support** 

# Challenge 1: Automated analysis of Feature Models

Computer-aided, extraction of useful information from feature models



## **Analysis process**



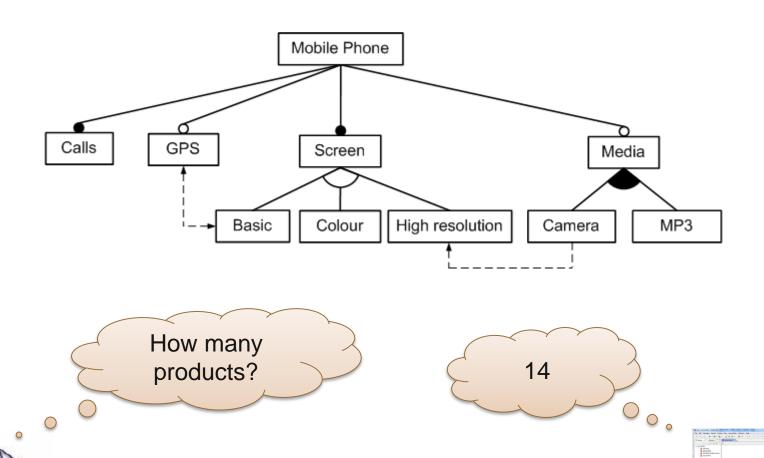
#### Feature models as CSPs

# Feature Model Constraint Satisfaction Problem Translation Constraint Satisfaction Problem

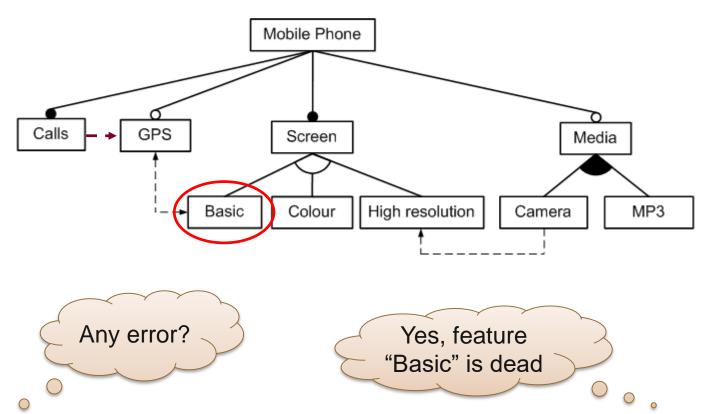
# Feature models as Propositional formulas

SS B A → B A → B	PL Mapping	
MANDATORY	<u>в</u> С	$P \leftrightarrow C$
OPTIONAL	Ţ	$C \rightarrow P$
OR		$P \leftrightarrow (C_1 \lor C_2 \lor \lor C_n)$
ALTERNATIVE		
IMPLIES	A→ B	$A \rightarrow B$
EXCLUDES	A ■ B	¬(A∧B)

# Automated analysis of feature models: Computer-aided extraction of information from FMs

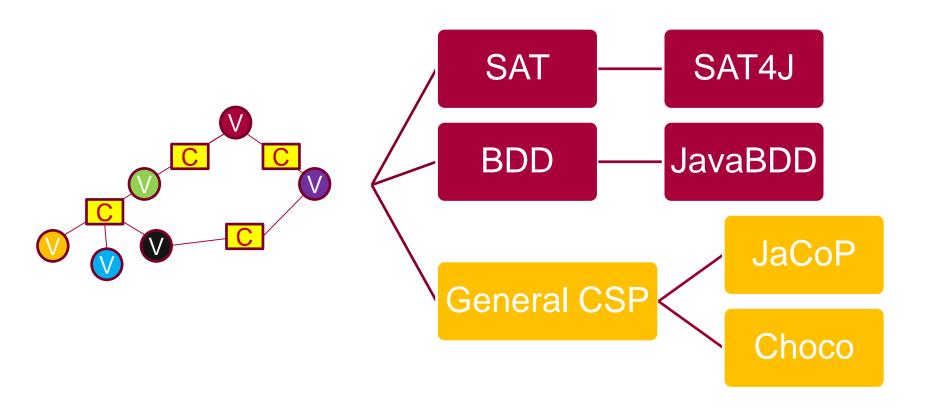


#### Automated analysis of feature models: Computer-aided extraction of information from FMs

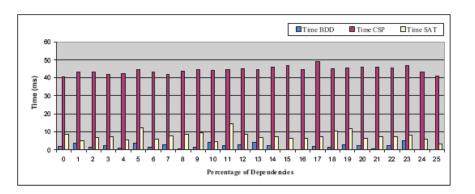


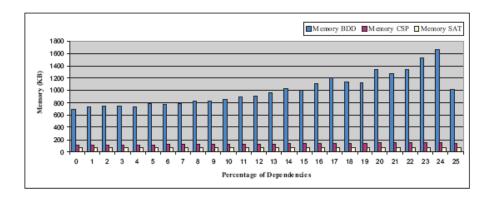


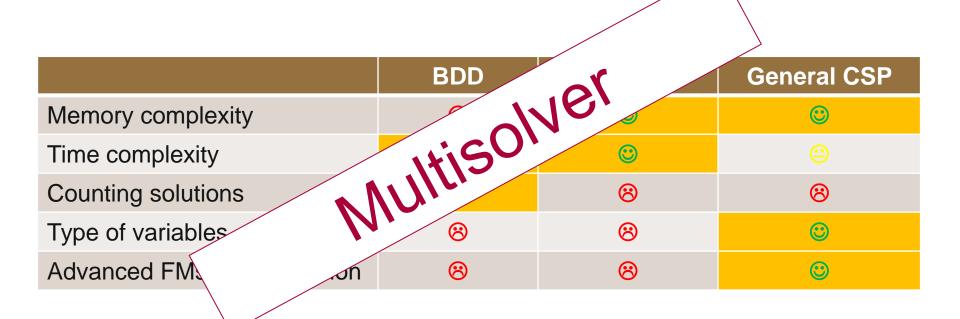
### **Analysis implementations**



#### Different solvers, different performance







# Automated analysis of SPL Why it's an important problem?

Doing this by hand is an error prone task in large-scale feature models

Detecting properties at early stage of development and along all the life cycle

It's the base for other more complicated tasks, i.e. product configuration

## **Challenge 1: Automated analysis of SPL:**

Computer-aided, extraction of useful information from SPL models

	Batory [5]	Czamecki et al. [30]	Gheyi et al. [37]	Mannion et al. [51, 52]	Mendonca et al. [57]	Mendonca et al. [56]	Sun et al. [74]	Thüm et al. [75]	van der Storm [86, 87]	Zhang et al. [102, 101]	Zhang et al. [103]	Yan et al. [100]	Benavides et al. [10, 11, 12]	Benavides et al. [15]	Djebii et al. [34]	Trinidad et al. [78, 76]	White et al. [99]	White et al. [97]	Abo Zaid et al. [1]	Fan et al. [35]	Wang et al. [92, 93]	Benavides et al. [14]	Benavides et al. [16]	Segura [70]	Bachmeyer et al. [4]	Cao et al. [20]	Fernandez et al. [36]	Hemakumar [41]	Gheyi et al. [38]	Kang et al. [43]	Mendonca et al. [55]	Osman et al. [59, 60]	Salinesi et al. [66]	Van den Broek et al. [84]	Van Deursen et al. [88]	Von der Massen et al. [90]	Von der Massen et al. [91]	White et al. [98, 96]	Batory et al. [Z]	Schobbens et al. [42, 68, 69]	Trinidad et al. [80]	Von der Massen et al. [89]
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Valid product	+	+	+	+			+										+				+				+					0						+			~	~	~	
All products	+		+	0			+						+										+			+								+	0						~	
Explanations	+	~					+									+			+		+									0		+		+					~		~	
Refactoring			+				0	+													+								+											~	~	
Optimization													0		+																	+						+	~		~	
Commonality													0			+							+				+														~	
Filter		+											0		+																			+							~	
Valid partial configuration	+	+							+																					0											~	
Atomic sets					+					0			1											+							+											
False optional features										0	+					+																									~	0
Corrective explanations																	+															+										0
Dependency analysis													ii –											i						0	+							i				
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Generalization			0					+					ii .											i i														i				
Core features					i –	+	1		i -				ii –											i							i										ө	
Variability factor													0																									i			~	
Arbitrary edit								+																																		
Conditional dead features													ii .											i				+										i				
Homogeneity																											+															
LCA					+								ii .																													
Muti-step configuration																		+																								
Roots features					+																																					
Specialization								+																																		
Degree of orthogonality		~						1																																		
Redundancies																																										~
Variant features																																									~	
Wrong cardinalities																																									~	
Feature model notation	D	C	В	В	В	В	В	В	В	В	C	В	В	C	C	В	В	D	В	В	В	В	С	В	В	В	C	В	В	В	С	C	C	В	В	В	В	В	В	С	C	В
Extended feature model	D		Б	D	Б	D	Б	D	D	D		D		C		D		В		D	D	D		D	Д	D		D	D				C	Б	D	D	D			C		Б
Formalization			+		+		+	+		+	+		+		+	+	+	+	+	+					+		+		+	+		+					+	+	+	+	+	-
FORMALIZATION			port		+	+	~		supp		+		+	Sur						+					+		+		+			+					+		featur			



Table 3: Summary of operations and support

David Benavides, Sergio Segura, Antonio Ruiz Cortés: <u>Automated analysis of feature models 20 years later: A literature review</u>. Inf. Syst. 35(6): 615-636 (2010)

```
SPL model: Model [SPL characteristic model] features: \mathbb{F}_1 Feature [SPL feature set] \Phi \ model = features [other invariants can be added in the CML]
```

```
\neg \prec \_: Product \leftrightarrow SPL
\forall p : Product; \ spl : SPL \bullet
p \prec spl \Leftrightarrow
(\ p \subseteq spl.features \land \ p \prec spl.model)
```

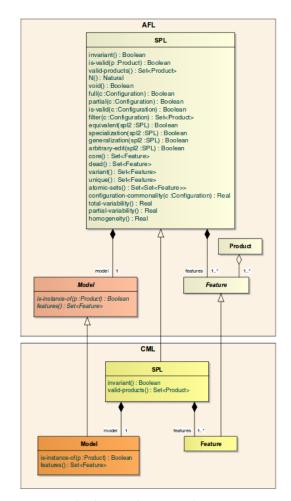
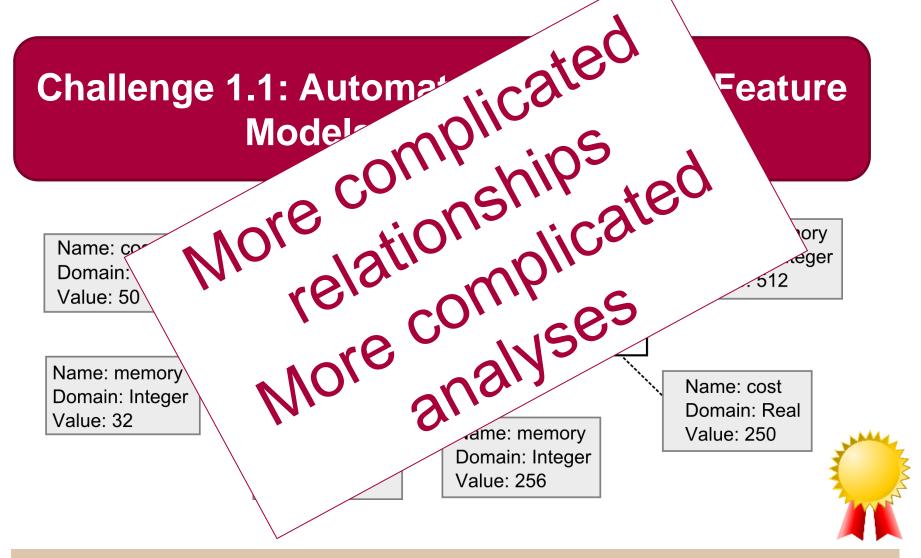


Fig. 3 UML class diagram of the FLAME architecture

Amador Durán, David Benavides, Sergio Segura, Pablo Trinidad, Antonio Ruiz Cortés: <u>FLAME: a formal framework for the automated analysis of software product lines validated by automated specification testing</u>. Software and System Modeling 16(4): 1049-1082 (2017)

# Are boolean feature modes enough?



- David Benavides, Pablo Trinidad Martín-Arroyo, Antonio Ruiz Cortés: <u>Automated</u> <u>Reasoning on Feature Models</u>. CAiSE 2005: 491-503
- F Roos-Frantz, D Benavides, A Ruiz-Cortés, A Heuer, K Lauenroth

  <u>Quality-aware analysis in product line engineering with the orthogonal variability</u>

  model. Software Quality Journal

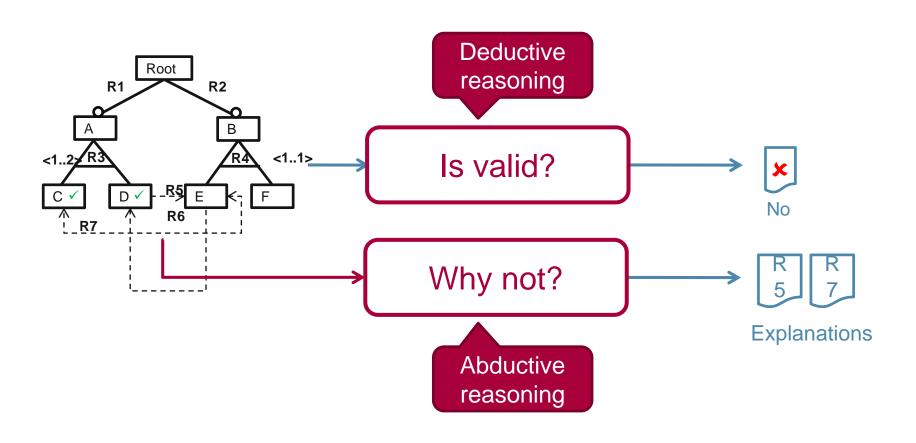
#### Formal methods

First stop: Automated Analysis of FM Second stop: Explanations on FM analysis

Third stop: Testing on FM analysis tools Forth stop:
Applications
of the
Automate
analysis of
feature
models

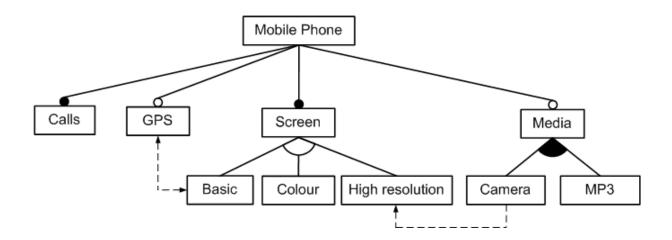
Tool support

# Challenge 2: Explanations on the Automated analysis of SPL

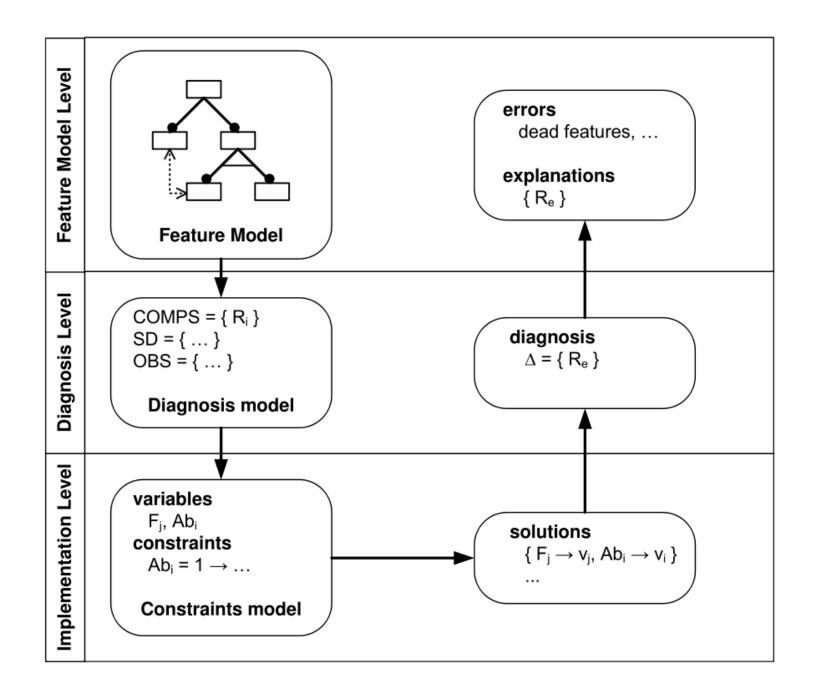


# Challenge 2: Explanations on the Automated analysis of SPL

#### Ch 2.1 with feature models



Pablo Trinidad, David Benavides, Amador Durán, Antonio Ruiz Cortés, Miguel Toro: <u>Automated error analysis for the agilization of feature modeling</u>. Journal of Systems and Software 81(6): 883-896 (2008)



## Challenge 2: Explanations on the Automated analysis of SPL

Ch 2.2 with configurations





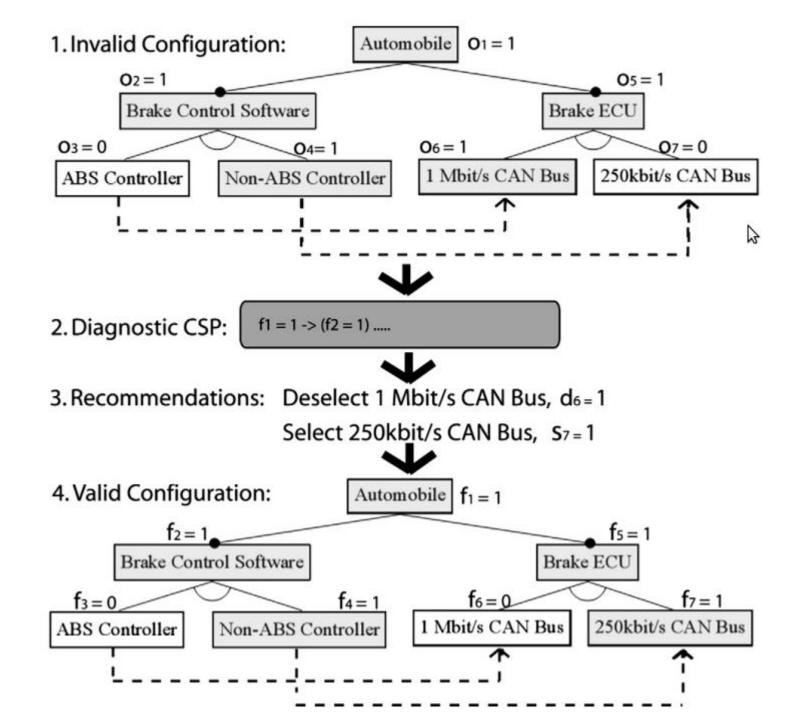






Jules White, David Benavides, Douglas C. Schmidt, Pablo Trinidad, Brian Dougherty, Antonio Ruiz Cortés: <u>Automated diagnosis of feature model configurations</u>. Journal of Systems and Software 83(7): 1094-1107 (2010)

Alexander Felfernig, Rouven Walter, José A. Galindo, David Benavides, Seda Polat Erdeniz, Müslüm Atas, Stefan Reiterer: <u>Anytime Diagnosis for Reconfiguration</u>. J. Intell. Inf. Syst. 51(1): 161-182 (2018)



#### Formal methods

First stop: Automated Analysis of FM

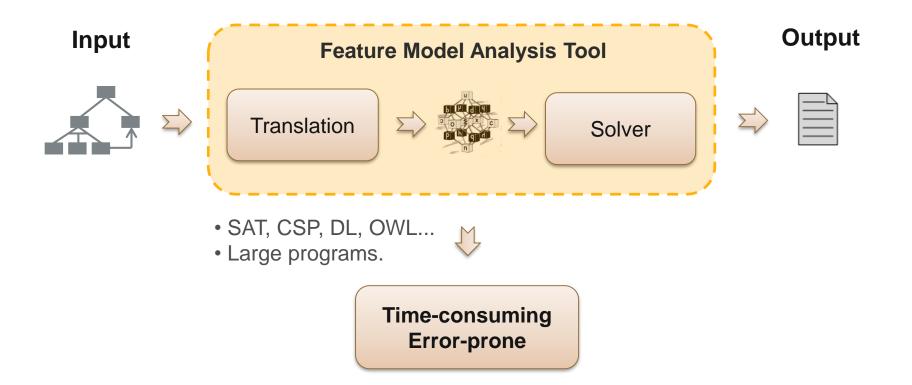
Second stop: Explanations on FM analysis Third stop: Testing on FM analysis tools

Forth stop:
Applications
of the
Automate
analysis of
feature
models

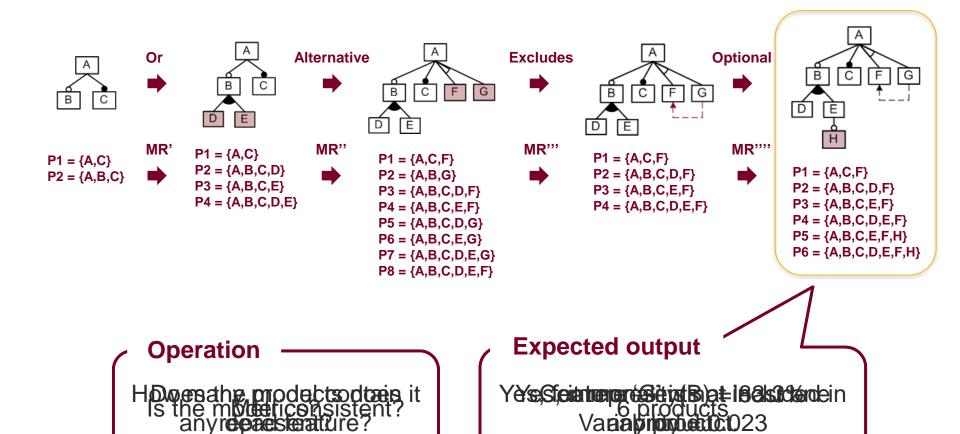
**Tool support** 

## Functional Testing

How to detect faults in feature model analysis tools?



## **Functional Testing**





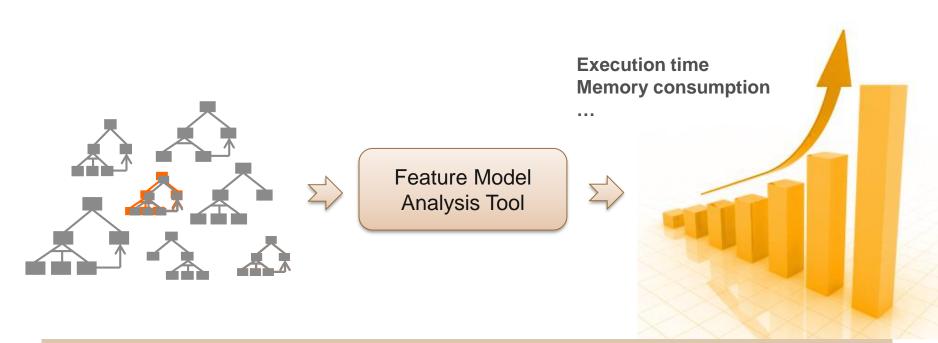
Sergio Segura, Robert M. Hierons, David Benavides, Antonio Ruiz Cortés: <u>Automated metamorphic testing on the analyses of feature models</u>. Information & Software Technology 53(3): 245-258 (2011)

## **Challenge 3.1: Functional Testing**

	FM	FM'	Metamorphic relation		
MANDATORY	B C B C D		# products(FM') =# products(FM) $\land \forall P'(P' \in products(FM') \Leftrightarrow \exists P \in products(FM)) \land (pf \in features(P) \land P' = P \cup \{f\}) \lor (pf \notin features(P) \land P' = P))$		
OPTIONAL	B	BCD	# $products(FM') = \# products(FM) + filter(FM, \{pf\}, \phi) \land \forall P'(P' \in products(FM') \Leftrightarrow \exists P \in products(FM) \cdot P' = P \lor (pf \in features(P) \land P' = P \cup \{f\}))$		
ALTERNATIVE	A C	A B C D E	# products(FM') =# products(FM) + (#C-1)# filter(FM, { pf }, $\phi$ ) $\land$ $\forall P'(P' \in products(FM') \Leftrightarrow \exists P \in products(FM) \cdot$ $(pf \in features(P) \land \exists c \in C \cdot P' = P \cup \{c\}) \lor (pf \notin features(P) \land P' = P))$		
OR	ABC	BCDE	# products(FM') =# products(FM) + $(2^{\#C} - 1)$ # filter(FM, {pf}, $\phi$ ) $\wedge$ $\forall P'(P' \in products(FM') \Leftrightarrow \exists P \in products(FM) \cdot$ $(pf \in features(P) \wedge \exists S \in \wp(C) \cdot P' = P \cup S) \vee (pf \notin features(P) \wedge P' = P)))$		
REQUIRES	ABC	A BC	$products(FM') = products(FM) \setminus filter(FM, \{f\}, \{g\})$		
EXCLUDES	A B C	A B C	$products(FM') = products(FM) \setminus filter(FM, \{f, g\}, \phi)$		

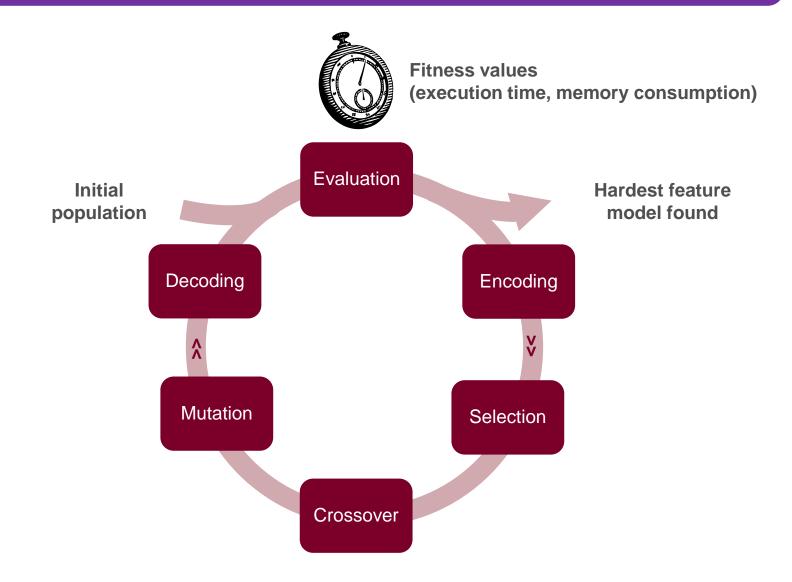
## Performance Testing

How to know the performance of FM analysis tools in pessimistic cases?



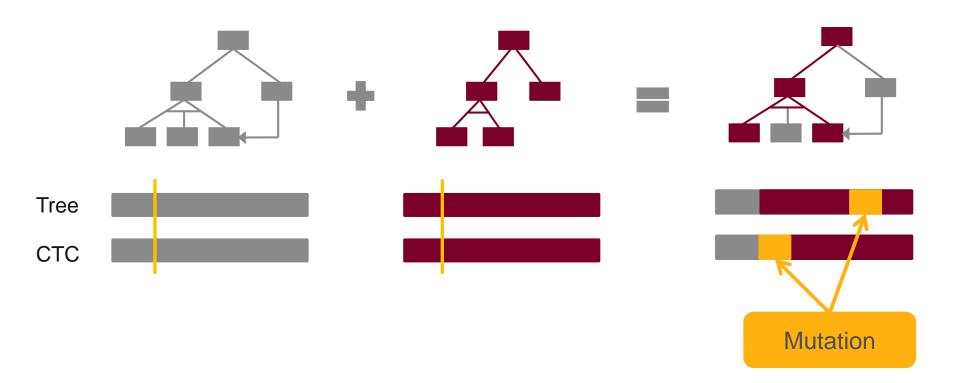
Sergio Segura, José Antonio Parejo, Robert M. Hierons, David Benavides, Antonio Ruiz Cortés: <u>Automated generation of computationally hard feature models using evolutionary algorithms</u>. Expert Syst. Appl. 41(8): 3975-3992 (2014)

## **Challenge 3.2: Performance Testing**



## **Challenge 3.2: Performance Testing**

**Encoding - Crossover - Mutation** 



## **Challenge 3.2: Performance Testing**

> 30 minutes



27.9x10<sup>6</sup> nodes 25.3x10<sup>6</sup> nodes

6.7 minutes 4.2 minutes (x2)

0.2 seconds



## Formal methods

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analysis of
feature
models

Tool support



#### Automated analysis of feature models: Quo vadis?

José A. Galindo<sup>1</sup> · David Benavides<sup>1</sup> · Pablo Trinidad<sup>1</sup> · Antonio-Manuel Gutiérrez-Fernández<sup>1</sup> · Antonio Ruiz-Cortés<sup>1</sup>

Received: 23 March 2017 / Accepted: 18 July 2018 © Springer-Verlag GmbH Austria, part of Springer Nature 2018

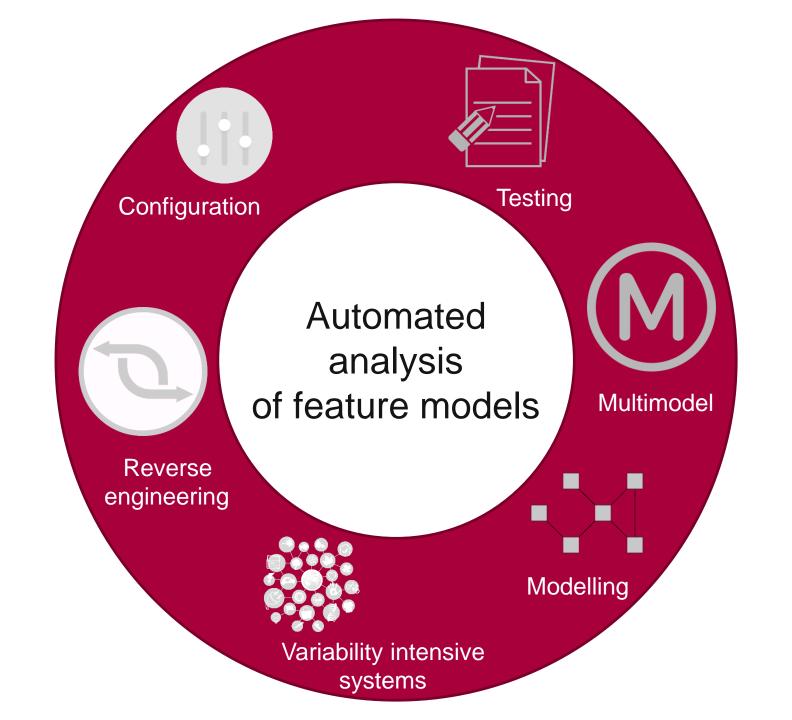
#### **Abstract**

Feature models have been used since the 90s to describe software product lines as a way of reusing common parts in a family of software systems. In 2010, a systematic literature review was published summarizing the advances and settling the basis of the area of automated analysis of feature models (AAFM). From then on, different studies have applied the AAFM in different domains. In this paper, we provide an overview of the evolution of this field since 2010 by performing a systematic mapping study considering 423 primary sources. We found six different variability facets where the AAFM is being applied that define the tendencies; product configuration and derivation; testing and evolution; reverse engineering; multi-model variabilityanalysis; variability modelling and variability-intensive systems. We also confirmed that there is a lack of industrial evidence in most of the cases. Finally, we present where and when the papers have been published and who are the authors and institutions that are contributing to the field. We observed that the maturity is proven by the increment in the number of journals published along the years as well as the diversity of conferences and workshops where papers are published. We also suggest some synergies with other areas such as cloud or mobile computing among others that can motivate further research in the future.

#### Some results from the literature

Variability context facet	Product configuration and derivation	4	9	15	40	1	3
	Testing and _ evolution	4	5	8	44	4	0
	Reverse _ engineering	2	4	4	12	2	0
	Multi-model _ variability analysis	2	2	5	13	3	0
	Variability _ modelling	3	9	15	28	8	0
	Variability-intensive systems analysis	1	3	1	14	5	0
		Opinion Paper	Philosophical Paper	Solution Proposal <b>Resear</b> e	Evaluation Research ch facet	Validation Research	Experience Report

Fig. 11: Visualization of the systematic map



## Formal methods

Challenge 1:
Automated
Analysis of
FM

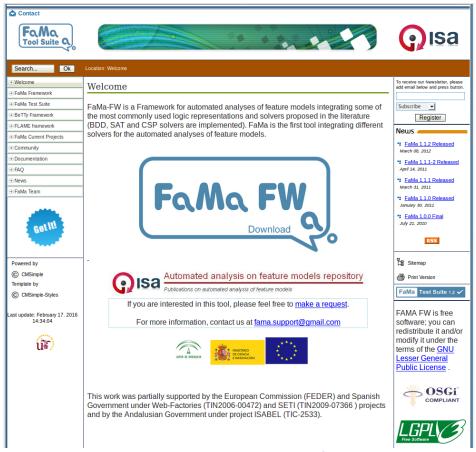
Challenge 2: Explanations on FM analysis

Testing on FM analysis tools

Challenge 4:
Applications
of the
Automate
analysis of
feature
models

## Tool support

## **Tooling the Automated analysis of SPL**



www.isa.us.es/fama
https://github.com/isa-group/FaMA

#### **FAMA Architecture**





FaMa Benchmarking System ✓

#### **Public interfaces**



SPL Core

Czarne cki Moskitt

Metamodels

Valid #Prod

Explain Errors

Operations

JaCoP Choco

Java BDD SAT4j

Reasoners

Selector

Atomic ...
Sets ...

Transformations

Best

FAMA Extensions

## **Tooling the Testing of FM analysis tools**

**Be**nchmarking and **TesTing** on the analysis of feature models



https://betty.services.governify.io/ https://github.com/isa-group/BeTTy

Metamorphic test data generation

Evolutionary FM generation

Random FM generation

Benchmarking support

## Formal methods

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feature
models

Tool support

# Intermediate stop in the journey (ICSR 2013)

## Automated Analysis in Feature Modelling and Product Configuration

David Benavides<sup>1</sup>, Alexander Felfernig<sup>2</sup>, José A. Galindo<sup>1</sup>, and Florian Reinfrank<sup>2</sup>

<sup>1</sup> University of Seville
Av. de la Reina Mercedes S/N, 41012 Seville, Spain {benavides, jagalindo}@us.es
<sup>2</sup> Institute for Software Technology
Graz University of Technology
Inffeldgasse 16b/II
Graz, Austria
{afelfern,freinfra}@tugraz.at



# Feature model analysis and configuration: a 10 years journey with configuration stops

**David Benavides** 

<u>benavides@us.es</u>

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